

## **Measurement Hardware / Instrumentation**

## Spectroscopy

Fluorescence Lifetime Measurements Time-Resolved Fluorescence Anisotropy Measurements Time Resolved Emission Spectra (TRES) Measuring the Quantum Yield with the integrating Sphere assembly for the FT300 EasyTau Scripts Some origins of multiexponetial decays for pure dyes

## Microscopy

Quick Reference for Confocal Time-resolved Microscopy (FLIM, FRET, FCS) - Poster (pdf format)Fluorescence and fluorescence microscopy by Nico StuurmanConfocal microscoy and optical sectioning by Kurt ThornBeampath of the Zeiss LSM880How to check the overlap of different color confocal volumesDetermination of the focal width with the focal width analysisTwo Photon Microscopy (TPM, TPE) by Kurt ThornAdvantages and disadvantages of Two Photon Excitation (TPE)How to measure the Instrument Response function (IRF)FLIM Measurement using a Nikon A1 with a FLIM and FCS upgradeRecording a Fluorescence Lifetime Image (FLIM) Stack with a LSM Upgrade Kit on a Nikon A1FLIM-FRET Measurement using an Olympus FV1200 with a FLIM and FCS upgradePerforming an FCS measurement with an Olympus FV1200 upgrade kitHow to exchange the main dichroic of the MicroTIme 200.Photon antibunching measurements

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PicoQuant GmbH Rudower Chaussee 29 (IGZ) 12489 Berlin Germany P +49-(0)30-1208820-89 F +49-(0)30-1208820-90 info@picoquant.com www.picoquant.com